

Search Notes

Application/Control No.

10/078,061

Examiner

Ellen C. Tran

Applicant(s)/Patent under
Reexamination

CHEN ET AL.

Art Unit

2134

SEARCHED

Class	Subclass	Date	Examiner
726	6	3/25/2006	ECT
726	3	3/25/2006	ECT
726	11	3/25/2006	ECT
726	13	3/25/2006	ECT
726	14	3/25/2006	ECT
726	12	3/31/2006	ECT
709	242	3/31/2006	ECT

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
USPTO, USPG, EPO, JPO, DERWENT, IBM TECH DES	3/25/2006	ECT
INVENTOR SEARCH, PALM, dDan, USPTO	3/25/2006	ECT
NPL - IEEE Xplore	3/25/2006	ECT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
Interference Search		3/25/2006	ECT